Notice of References Cited Application/Control No. 10/623,286 Examiner Devona E. Faulk Applicant(s)/Patent Under Reexamination FINN ET AL. Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,442,712	08-1995	Kawamura et al.	381/83
*	В	US-2004/0158460	08-2004	Finn et al.	704/205
*	С	US-6,252,969	06-2001	Ando, Shigeo	381/103
*	D	US-6,125,187	09-2000	Hanajima et al.	381/83
	E	US-			
	F	US-			
	G	US-			
·	Н	US-			
	ı	US-			
	J	US-			
	к	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
i.	0					
	Р					
	Q					
	R					
	s	,				
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	×	

^{*}A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.